Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10736690	ARELLANO ET AL.	
Examiner	Art Unit	
Parker, Brandon	2174	

SEARCHED					
Class		Subclass	Date	Examiner	
715	863		2/1/07	BP	
715	530		2/1/07	BP	
715	764		2/1/07	BP	
715	762		2/2/07	BP	

SEARCH NOTES	S	
Search Notes	Date	Examiner
SEARCHED IEEE AND ACM	2/1/07	BP

	INTERFERENCE SEARCH		
Class	Subclass	Date	Examiner

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